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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/689,250	EVANS ET AL.	
Examiner	Art Unit	
Benny Q. Tieu	2614	

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Class	Subclass	Date	Examiner
379	207.04- 207.09 207.16 211.01	9/29/2006	BQT
	211.04 252		
	256 372 377		
	378 418		
455	414.1 417		
	462 465		
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INT	INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH)
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Interference Search History Printout	9/29/2006	вот